

AON2408

20V N-Channel MOSFET

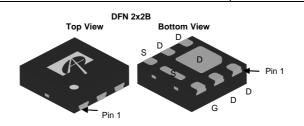
General Description

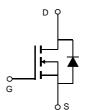
The AON2408 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for load switch and battery protection applications.

Product Summary

 $\begin{array}{lll} V_{DS} & 20V \\ I_{D} \; (at \; V_{GS} \! = \! 4.5V) & 8A \\ R_{DS(ON)} \; (at \; V_{GS} = \! 4.5V) & < 14.5 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} = \! 2.5V) & < 19 m\Omega \end{array}$







Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	20	V
Gate-Source Voltage		V _{GS}	±12	V
Continuous Drain	T _A =25℃		8	
Current G	T _A =100℃	'D	6	A
Pulsed Drain Current C		I _{DM}	32	
	T _A =25℃	Ь	2.8	W
Power Dissipation ^A	ver Dissipation ^A T _A =70℃		1.8	VV
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C

Thermal Characteristics							
Parameter	Symbol	Тур	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	37	45	C/W		
Maximum Junction-to-Ambient AD	Steady-State	$\kappa_{\theta JA}$	66	80	C/W		



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		20			V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =20V, V_{GS} =0V				1	μА
	2510 Gate Voltage Brain Garrent		T _J =55℃			5	μπ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±12V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		0.5	0.83	1.2	V
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V		32			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =4.5V, I_{D} =8A			11.6	14.5	m()
			T _J =125℃		16.3	20.5	mΩ
		V_{GS} =2.5V, I_D =4A			15	19	mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =8A			50		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.65	1	V
Is	Maximum Body-Diode Continuous Curr			3.5	Α		
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance				782		pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz			158		pF
C _{rss}	Reverse Transfer Capacitance				98		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			2.4		Ω
SWITCHI	NG PARAMETERS						
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =10V, I _D =8A			7		nC
Q_{gs}	Gate Source Charge				1		nC
Q_{gd}	Gate Drain Charge				2.4		nC
t _{D(on)}	Turn-On DelayTime				3		ns
t _r	Turn-On Rise Time	V_{GS} =4.5V, V_{DS} =10V, R_L =1.25 Ω , R_{GEN} =3 Ω			4.5		ns
t _{D(off)}	Turn-Off DelayTime				28		ns
t _f	Turn-Off Fall Time				6		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =8A, dI/dt=100A/μs			11		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =8A, dI/dt=100A/μs			2.7		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R $_{\theta JA}$ t \leq 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

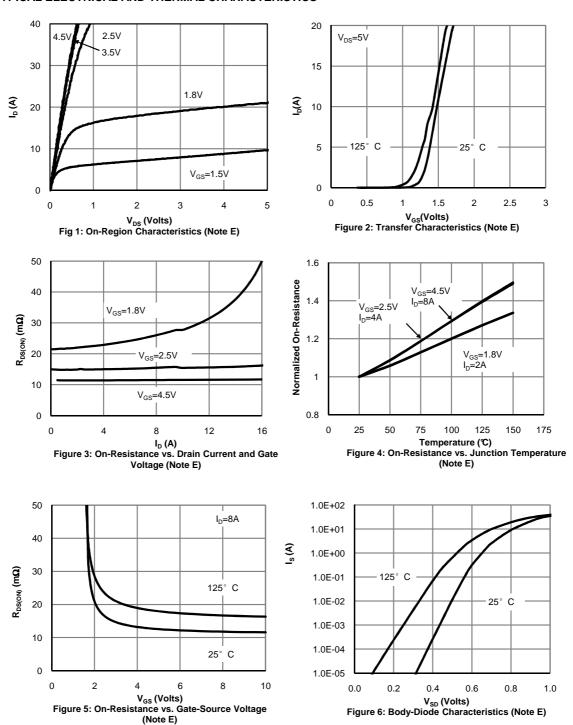
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C.



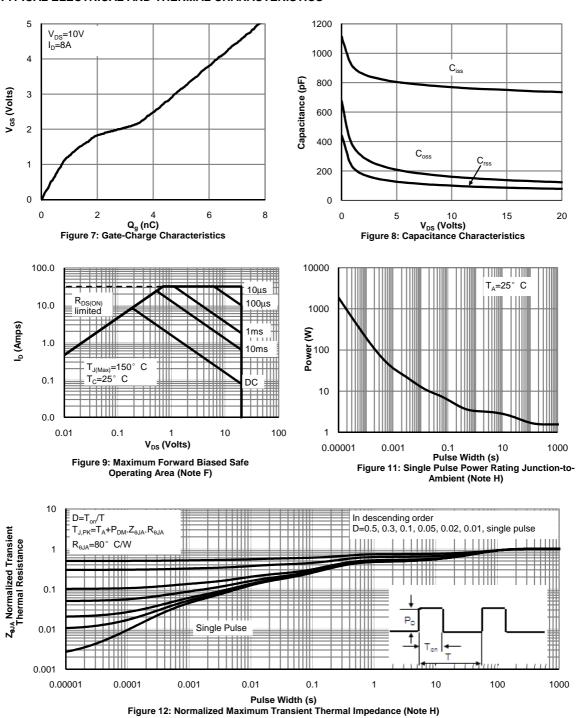
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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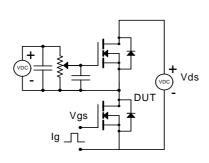


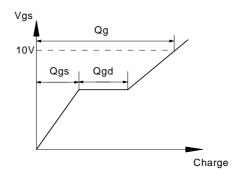
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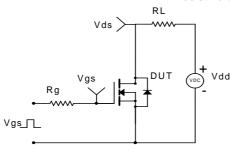


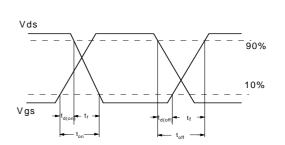
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

